	Туре	<u>L #</u>	<u>Hits</u>	Search Text	<u>DBs</u>
1	IS&R	<u>L1</u>	<u>10</u>	(("4,047,435") or ("4,896,196") or ("5,049,961") or ("5,119,265") or ("5,726,481") or ("6,268,986") or ("6,291,826") or ("6,342,997") or ("6,363,490") or ("20040017437")).PN.	US- PGPUB; USPAT
2	BRS	<u>L2</u>	5336	temperature adj2 sensing adj2 (devices or device)	US- PGPUB; USPAT
3	BRS	<u>L3</u>	180	2 and (cathode near10 anode)	US- PGPUB; USPAT
4	BRS	<u>L4</u>	102	3 and (diode or diodes)	US- PGPUB; USPAT
<u>5</u>	BRS	<u>L5</u>	<u>11</u>	4 and ((semiconductor or silicon) adj2 (substrate))	US- PGPUB; USPAT
6	BRS	<u>L6</u>	1768	temperature adj2 sensing adj2 (devices or device)	USOCR; EPO; JPO; DERWE NT; IBM TD B
7	BRS	<u>L7</u>	<u>38</u>	6 and (cathode near10 anode)	USOCR; EPO; JPO; DERWE NT; IBM TD B

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	Type	<u>L</u> #	Hits	Search Text	<u>DBs</u>
8	<u>BRS</u>	<u>L8</u>	<u>18</u>	7 and (diode or diodes)	USOCR; EPO; JPO; DERWE NT; IBM TD
9	BRS	<u>L9</u>	50211	sensing adj2 (devices or device)	US- PGPUB; USPAT
10	BRS	L10	1683	9 and (cathode near10 anode)	US- PGPUB; USPAT
11	BRS	L11	1104	10 and (diode or diodes)	US- PGPUB; USPAT
12	BRS	L12	82	11 and ((semiconductor or silicon) adj2 (substrate))	US- PGPUB; USPAT
13	<u>BRS</u>	L13	26497	sensing adj2 (devices or device)	USOCR; EPO; JPO; DERWE NT; IBM TD B
14	BRS	<u>L14</u>	668	13 and (cathode near10 anode)	USOCR; EPO; JPO; DERWE NT; IBM TD B

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	Type	<u>L #</u>	Hits	Search Text	DBs
<u>15</u>	<u>BRS</u>	L15	<u>391</u>	14 and (diode or diodes)	USOCR; EPO; JPO; DERWE NT; IBM TD B
16	<u>BRS</u>	L16	2	15 and ((semiconductor or silicon) adj2 (substrate))	USOCR; EPO; JPO; DERWE NT; IBM TD B
17	IS&R	L17	<u>461</u>	(257/467).CCLS.	US- PGPUB; USPAT
18	IS&R	L19	<u>515</u>	(257/659).CCLS.	US- PGPUB; USPAT
19	IS&R	L18	142	(257/470).CCLS.	US- PGPUB; USPAT